

## Functional Description

The LCX157 is a quad 2-input multiplexer. It selects four bits of data from two sources under the control of a common Select input (S). The Enable input ( $\overline{\mathrm{E}}$ ) is active-LOW. When $\overline{\mathrm{E}}$ is HIGH, all of the outputs $(\mathrm{Z})$ are forced LOW regardless of all other inputs. The LCX157 is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select input. The logic equations for the outputs are shown below:

$$
\begin{aligned}
& Z_{\mathrm{a}}=\overline{\mathrm{E}} \cdot\left(\mathrm{I}_{\mathrm{a}} \cdot \mathrm{~S}+\mathrm{I}_{\mathrm{oa}} \cdot \overline{\mathrm{~S}}\right) \\
& \mathrm{Z}_{\mathrm{b}}=\overline{\mathrm{E}} \cdot\left(\mathrm{I}_{\mathrm{ib}} \cdot \mathrm{~S}+\mathrm{I}_{\mathrm{ob}} \cdot \overline{\mathrm{~S}}\right) \\
& \mathrm{Z}_{\mathrm{c}}=\overline{\mathrm{E}} \cdot\left(\mathrm{I}_{\mathrm{cc}} \cdot \mathrm{~S}+\mathrm{I}_{\mathrm{oc}} \cdot \overline{\mathrm{~S}}\right) \\
& \mathrm{Z}_{\mathrm{d}}=\overline{\mathrm{E}} \cdot\left(\mathrm{I}_{1 \mathrm{~d}} \cdot \mathrm{~S}+\mathrm{I}_{\mathrm{od}} \cdot \overline{\mathrm{~S}}\right)
\end{aligned}
$$

A common use of the LCX157 is the moving of data from two groups of registers to four common output busses. The particular register from which the data comes is determined by the state of the Select input. A less obvious use is as a function generator. The LCX157 can generate any four of the six-

## Logic Diagram

teen different functions of two variables with one variable common. This is useful for implementing gating functions.

Truth Table

| Inputs |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
| $\overline{\mathbf{E}}$ | S | $\mathrm{I}_{\mathbf{0}}$ | $\mathrm{I}_{\mathbf{1}}$ | Outputs |
| H | X | X | X | L |
| L | H | X | L | L |
| L | H | X | H | H |
| L | L | L | X | L |
| L | L | H | X | H |

H = HIGH Voltage Leve
L = LOW Voltage Level
$X=$ Immaterial


Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

## Absolute Maximum Ratings (Note 1)

| Symbol | Parameter | Value | Conditions | Units |
| :--- | :--- | :--- | :--- | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply Voltage | -0.5 to +7.0 |  | V |
| $\mathrm{~V}_{\mathrm{I}}$ | DC Input Voltage | -0.5 to +7.0 |  | V |
| $\mathrm{~V}_{\mathrm{O}}$ | DC Output Voltage | -0.5 to $\mathrm{V}_{\mathrm{CC}}+0.5$ | Output in High or Low State (Note 2) | V |
| $\mathrm{I}_{\mathrm{IK}}$ | DC Input Diode Current | -50 | $\mathrm{~V}_{\mathrm{I}}<\mathrm{GND}$ | mA |
| $\mathrm{I}_{\mathrm{OK}}$ | DC Output Diode Current | -50 | $\mathrm{~V}_{\mathrm{O}}<\mathrm{GND}$ | mA |
|  |  | +50 | $\mathrm{~V}_{\mathrm{O}}>\mathrm{V}_{\mathrm{CC}}$ |  |
| $\mathrm{I}_{\mathrm{O}}$ | DC Output Source/Sink Current | $\pm 50$ |  | mA |
| $\mathrm{I}_{\mathrm{CC}}$ | DC Supply Current per Supply Pin | $\pm 100$ |  | mA |
| $\mathrm{I}_{\mathrm{GND}}$ | DC Ground Current per Ground Pin | $\pm 100$ |  | mA |
| $\mathrm{~T}_{\text {STG }}$ | Storage Temperature | -65 to +150 |  | ${ }^{\circ} \mathrm{C}$ |

Recommended Operating Conditions (Note 3)

| Symbol | Parameter | Min | Max | Units |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply Voltage Operating | 2.0 | 3.6 | V |
|  | Data Retention | 1.5 | 3.6 |  |
| $\mathrm{V}_{1}$ | Input Voltage | 0 | 5.5 | V |
| $\mathrm{V}_{0}$ | Output Voltage HIGH or LOW State | 0 | $\mathrm{V}_{\mathrm{CC}}$ | V |
| $\mathrm{IOH}^{\prime} / \mathrm{l}_{\mathrm{OL}}$ | Output Current $\quad \mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}-3.6 \mathrm{~V}$ |  | $\pm 24$ | mA |
|  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$ |  | $\pm 12$ |  |
| $\mathrm{T}_{\mathrm{A}}$ | Free-Air Operating Temperature | -40 | 85 | ${ }^{\circ} \mathrm{C}$ |
| $\Delta \mathrm{t} / \Delta \mathrm{V}$ | Input Edge Rate, $\mathrm{V}_{\mathrm{IN}}=0.8 \mathrm{~V}-2.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC}}=3.0 \mathrm{~V}$ | 0 | 10 | ns/V |

Note 1: The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the Absolute Maximum Ratings. The "Recommended Operating
Conditions" table will define the conditions for actual device operation.
Note 2: $\mathrm{I}_{\mathrm{O}}$ Absolute Maximum Rating must be observed.
Note 3: Unused inputs must be held HIGH or LOW. They may not float.
DC Electrical Characteristics

| Symbol | Parameter | Conditions | $\mathrm{V}_{\mathrm{cc}}$ <br> (V) | $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min | Max |  |
| $\mathrm{V}_{\mathrm{IH}}$ | HIGH Level Input Voltage |  | 2.7-3.6 | 2.0 |  | V |
| $\mathrm{V}_{\text {IL }}$ | LOW Level Input Voltage |  | 2.7-3.6 |  | 0.8 | V |
| $\mathrm{V}_{\text {OH }}$ | HIGH Level Output Voltage | $\mathrm{l}_{\mathrm{OH}}=-100 \mu \mathrm{~A}$ | 2.7-3.6 | $\mathrm{V}_{\text {CC }}-0.2$ |  | V |
|  |  | $\mathrm{I}_{\mathrm{OH}}=-12 \mathrm{~mA}$ | 2.7 | 2.2 |  | V |
|  |  | $\mathrm{I}_{\mathrm{OH}}=-18 \mathrm{~mA}$ | 3.0 | 2.4 |  | V |
|  |  | $\mathrm{I}_{\mathrm{OH}}=-24 \mathrm{~mA}$ | 3.0 | 2.2 |  | V |
| $\mathrm{V}_{\text {OL }}$ | LOW Level Output Voltage | $\mathrm{I}_{\mathrm{OL}}=100 \mu \mathrm{~A}$ | 2.7-3.6 |  | 0.2 | V |
|  |  | $\mathrm{I}_{\text {OL }}=12 \mathrm{~mA}$ | 2.7 |  | 0.4 | V |
|  |  | $\mathrm{I}_{\text {OL }}=16 \mathrm{~mA}$ | 3.0 |  | 0.4 | V |
|  |  | $\mathrm{I}_{\mathrm{OL}}=24 \mathrm{~mA}$ | 3.0 |  | 0.55 | V |
| 1 | Input Leakage Current | $0 \leq \mathrm{V}_{1} \leq 5.5 \mathrm{~V}$ | 2.7-3.6 |  | $\pm 5.0$ | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {OFF }}$ | Power-Off Leakage Current | $\mathrm{V}_{1}$ or $\mathrm{V}_{0}=5.5 \mathrm{~V}$ | 0 |  | 10 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{CC}}$ | Quiescent Supply Current | $\mathrm{V}_{1}=\mathrm{V}_{\mathrm{CC}}$ or GND | 2.7-3.6 |  | 10 | $\mu \mathrm{A}$ |
|  |  | $3.6 \mathrm{~V} \leq \mathrm{V}_{1} \leq 5.5 \mathrm{~V}$ | 2.7-3.6 |  | $\pm 10$ | $\mu \mathrm{A}$ |
| $\Delta \mathrm{l}_{\mathrm{cc}}$ | Increase in $\mathrm{I}_{\text {CC }}$ per Input | $\mathrm{V}_{\mathrm{IH}}=\mathrm{V}_{\mathrm{CC}}-0.6 \mathrm{~V}$ | 2.7-3.6 |  | 500 | $\mu \mathrm{A}$ |

## AC Electrical Characteristics

| Symbol | Parameter | $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}, \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=500 \Omega$ |  |  |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V}$ |  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$ |  |  |
|  |  | Min | Max | Min | Max |  |
| $\mathrm{t}_{\text {PHL }}$ | Propagation Delay | 1.5 | 7.0 | 1.5 | 8.0 | ns |
| $\mathrm{t}_{\text {PLH }}$ | $\mathrm{S} \rightarrow \mathrm{Z}_{\mathrm{n}}$ | 1.5 | 7.0 | 1.5 | 8.0 |  |
| $\mathrm{t}_{\text {PHL }}$ | Propagation Delay | 1.5 | 7.0 | 1.5 | 8.0 | ns |
| $\mathrm{t}_{\text {PLH }}$ | $\overline{\mathrm{E}} \rightarrow \mathrm{Z}_{\mathrm{n}}$ | 1.5 | 7.0 | 1.5 | 8.0 |  |
| $\mathrm{t}_{\text {PHL }}$ | Propagation Delay | 1.5 | 5.8 | 1.5 | 6.3 | ns |
| $\mathrm{t}_{\mathrm{PLH}}$ | $I_{n} \rightarrow Z_{n}$ | 1.5 | 5.8 | 1.5 | 6.3 |  |
| toshl | Output to Output Skew |  | 1.0 |  |  | ns |
| $t_{\mathrm{OSLH}}$ | (Note 4) |  | 1.0 |  |  |  |

Note 4: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH to LOW ( $\mathrm{t}_{\mathrm{OSHL}}$ ) or LOW to HIGH ( $\mathrm{t}_{\mathrm{OSLH}}$ ).

Dynamic Switching Characteristics

| Symbol | Parameter | Conditions | $\mathrm{V}_{\mathrm{cc}}$ <br> (V) | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | Units |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Typical |  |
| V ${ }_{\text {LP }}$ | Quiet Output Dynamic Peak $\mathrm{V}_{\mathrm{OL}}$ | $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \mathrm{V}_{\mathrm{IH}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{IL}}=0 \mathrm{~V}$ | 3.3 | 0.8 | V |
| $\mathrm{V}_{\text {OLV }}$ | Quiet Output Dynamic Valley $\mathrm{V}_{\text {OL }}$ | $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \mathrm{V}_{\mathrm{IH}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{IL}}=0 \mathrm{~V}$ | 3.3 | -0.8 | V |

Capacitance

| Symbol | Corameter | Conditions | Typical | Units |
| :--- | :--- | :--- | :---: | :---: |
| $\mathrm{C}_{\mathrm{IN}}$ | Input Capacitance | $\mathrm{V}_{\mathrm{CC}}=$ Open, $\mathrm{V}_{\mathrm{I}}=0 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}$ | 7 | pF |
| $\mathrm{C}_{\mathrm{OUT}}$ | Output Capacitance | $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{I}}=0 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}$ | 8 | pF |
| $\mathrm{C}_{\mathrm{PD}}$ | Power Dissipation Capacitance | $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{I}}=0 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}, \mathrm{f}=10 \mathrm{MHz}$ | 25 | pF |

Physical Dimensions inches (millimeters) unless otherwise noted


16-Lead Molded Small Outline kPackage, EIAJ
Package Number M16D
Physical Dimensions inches (millimeters) unless otherwise noted (Continued)


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